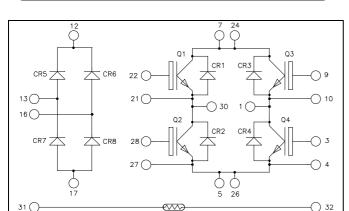
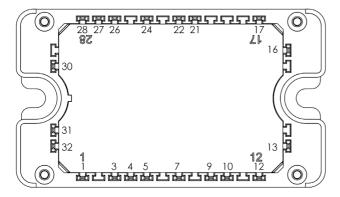


Full bridge + rectifier bridge Trench + Field Stop IGBT3 Power Module





All multiple inputs and outputs must be shorted together 7/24; 5/26

$V_{CES} = 600V$ $I_{C} = 50A$ @ $T_{C} = 80^{\circ}C$

Application

Solar converter

Features

- Trench + Field Stop IGBT3 Technology
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals both for power and signal for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

All ratings @ $T_i = 25$ °C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note

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1. Full bridge

Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage		600	V
$I_{\rm C}$	Continuous Collector Current	$T_C = 25^{\circ}C$	80	
	Continuous Conector Current	$T_C = 80$ °C	50	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_{D}	Maximum Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_{\rm J} = 150^{\circ}{\rm C}$	100A @ 550V	

Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μA
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
$V_{CE(sat)}$	Conector Emitter Saturation Voltage	$I_C = 50A$	$T_{j} = 150^{\circ}C$		1.7		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600 \mu A$		5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			600	nA

Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			3150		
Coes	Output Capacitance	$V_{CE} = 25V$			200		pF
C _{res}	Reverse Transfer Capacitance	f = 1MHz			95		
Q_{G}	Gate charge	$V_{GE}=\pm 15V, I_{C}=5$ $V_{CE}=300V$	50A		0.5		μС
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		110		
T_{r}	Rise Time	$V_{GE} = \pm 15V$			45		12 G
$T_{d(off)}$	Turn-off Delay Time	$\begin{array}{c} - V_{\text{Bus}} = 300V \\ I_{\text{C}} = 50A \end{array}$			200		ns
$T_{\rm f}$	Fall Time	$R_G = 8.2\Omega$			40		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			120		
T_{r}	Rise Time	$V_{GE} = \pm 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300\text{V}$ $I_{\text{C}} = 50\text{A}$			250		ns
$T_{\rm f}$	Fall Time	$R_G = 8.2\Omega$			60		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_j = 25$ °C		0.3		mJ
	<u> </u>	$V_{\text{Bus}} = 300V$ $I_{\text{C}} = 50A$	$T_j = 150^{\circ}C$		0.43		
E_{off}	Turn-off Switching Energy	$R_G = 8.2\Omega$	$T_{j} = 25^{\circ}C$ $T_{i} = 150^{\circ}C$		1.35		mJ
I_{sc}	Short Circuit data	$V_{GE} \le 15V \; ; V_{Bus} = 360V \ t_p \le 6\mu s \; ; T_i = 150^{\circ}C$			250		A
R_{thJC}	Junction to Case Thermal Resistance					0.85	°C/W



Reverse diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			600			V
I_{RM}	Maximum Reverse Leakage Current	V _R =600V	$T_j = 25$ °C			250	μA
1KM	Waxiindiii Reverse Beakage Carrent	VR COOV	$T_{j} = 150^{\circ}C$			500	μ21
I_{F}	DC Forward Current		$Tc = 80^{\circ}C$		50		A
V_{F}	Diode Forward Voltage	$I_F = 50A$	$T_i = 25^{\circ}C$		1.6	2	V
V F	Blode I of ward Voltage	$V_{GE} = 0V$	$T_i = 150$ °C		1.5		v
t _{rr}	Reverse Recovery Time		$T_j = 25$ °C		100		ns
· rr		, 50 A	$T_j = 150$ °C		150		115
Q_{rr}	Reverse Recovery Charge	$I_F = 50A$ $V_R = 300V$	$T_j = 25$ °C		2.6		μC
Qrr	Reverse Recovery Charge	$di/dt = 1800A/\mu s$	$T_{j} = 150^{\circ}C$		5.4		μС
E_{rr}	Reverse Recovery Energy		$T_j = 25$ °C		0.6		mJ
L _{rr}			$T_{\rm j} = 150^{\circ}{\rm C}$		1.2		1113
R_{thJC}	Junction to Case Thermal Resistance					1.42	°C/W

2. Rectifier bridge

Absolute maximum ratings (per diode)

Symbol	Paramet	er			Max ratings	Unit
V_R	Maximum DC reverse Voltage				600	V
V_{RRM}	Maximum Peak Repetitive Reverse Vo	ltage			000	v
$I_{F(AV)}$	Maximum Average Forward Current	Duty cycle	= 50%	$T_C = 80$ °C	40	Α
I_{FSM}	Non-Repetitive Forward Surge Current	t -	8.3ms	$T_J = 45^{\circ}C$	320	A

Electrical Characteristics (per diode)

Symbol	Characteristic	Test Conditions	ī.	Min	Тур	Max	Unit
		$I_F = 30A$			1.8	2.2	
V_{F}	Diode Forward Voltage	$I_F = 60A$	$I_F = 60A$		2.2		V
		$I_F = 30A$	$T_{j} = 125^{\circ}C$		1.5		
Ţ	Maximum Reverse Leakage Current	V = 600 V	$T_i = 25^{\circ}C$			250	4
I_{RM}		$V_R = 600V$	$T_{i} = 125^{\circ}C$			500	μΑ

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Dynamic Characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
t _{rr}	Reverse Recovery Time	$I_F=1A, V_R=30V$ $di/dt = 100A/\mu s$	$T_j = 25^{\circ}C$		22		ns	
t _{rr}	Reverse Recovery Time	$I_F = 30A$ $V_P = 400V$	$T_j = 25^{\circ}C$ $T_i = 125^{\circ}C$		25 160		ns	
Q _{rr}	Reverse Recovery Charge		$T_{j} = 25^{\circ}C$ $T_{i} = 125^{\circ}C$		35 480		nC	
I_{RRM}	Reverse Recovery Current		$T_{j} = 25^{\circ}C$ $T_{j} = 125^{\circ}C$		3		A	
t _{rr}	Reverse Recovery Time	$I_F = 30A$			85		ns	
Qrr	Reverse Recovery Charge	$V_R = 400V$ $di/dt = 1000A/\mu s$	-	$T_j = 125$ °C		920		μС
I_{RRM}	Reverse Recovery Current				20		A	
R_{thJC}	Junction to Case Thermal Resistance					1.2	°C/W	

3. Thermal and package characteristics

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C	rance @ 25°C				kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

Package characteristics

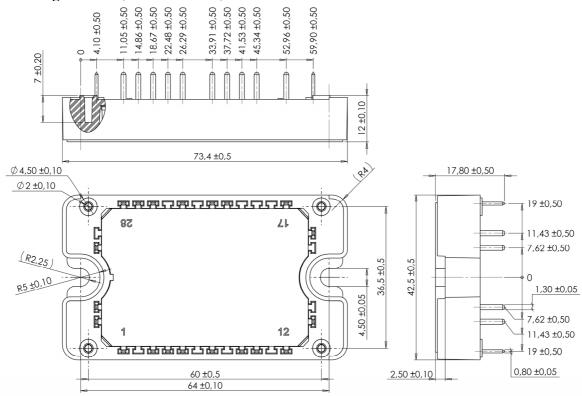
Symbol	Characteristic			Min	Тур	Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T_{J}	Operating junction temperature range			-40		175	
T_{STG}	Storage Temperature Range			-40		125	°C
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2		3	N.m
Wt	Package Weight		·			110	g

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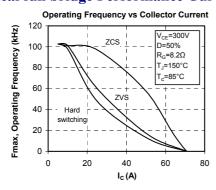
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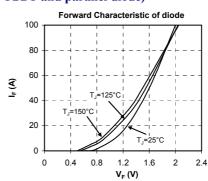


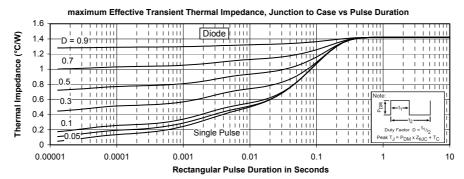
SP3 Package outline (dimensions in mm)



4. Typical full bridge Performance Curve (per IGBT and parallel diode)

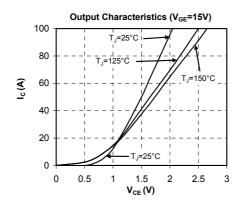


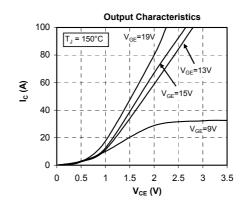


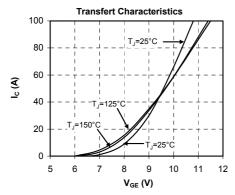


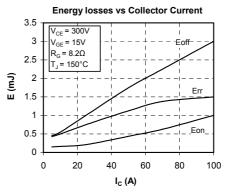
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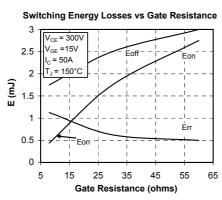


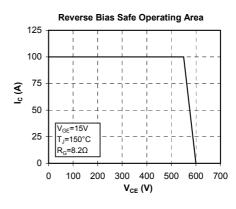


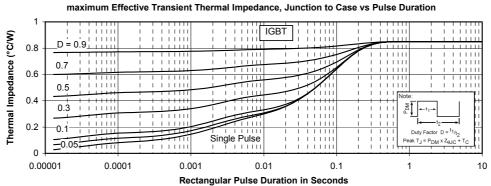








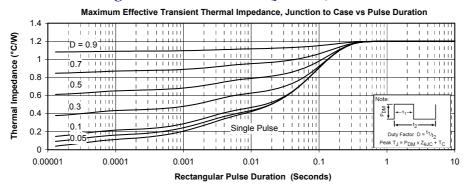


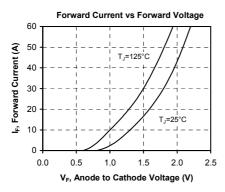


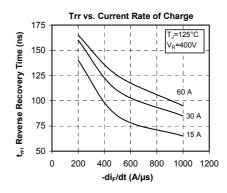
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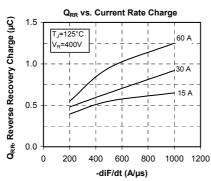


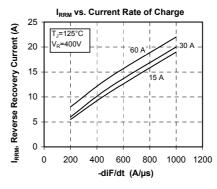
5. Typical rectifier bridge Performance Curve (per diode)

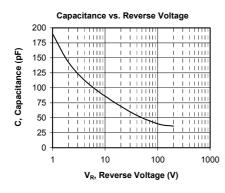














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